FORM PTO-		9 U. S DEPARTMENT OF COMMERCE PATE ND TRADEMARK OFFICE			C. DOCKET NO.	SERIAL NO.		
INFORMATION DISCLOSURE				U 01585 10/542,123 APPLICANT				
STATEMENT BY APPLICANT				Vladimir Pavlovich POPOV et al.				
(Use several sheets if necessary)				FILING DATE		GROUP		
		**		PI	12/9/05		2823	
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EXAMINER INITIALS	REFERENCE DESIGNATION	DOCUMENT NUMBER	DATE		NAME		FILING DATE IF APPROPRIATE	
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		NUMBER	DAT	E	COUNTRY	·	YES	NO
QVJ	AL	2 164 719	03/2001		RU		х	
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•	OTI	IER ART (Includi	ng Author, T	itle, Date	, Pertinent Dates, Etc.	.)		
QVJ	AQ	Partial English' Translation of RU 2 164 719 dated March 27, 2001						
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EXAMINER C	Quovaunda Jefferson DATE CONSIDERED 06/05/2006							
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								